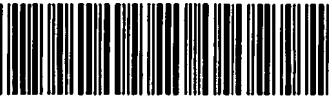


<b>Search Notes</b> 				Application/Control No.	Applicant(s)/Patent under Reexamination	
				10/613,228	KRIEG, ARTHUR M.	
				Examiner	Art Unit	
				N. M. Minnifield	1645	
<b>SEARCHED</b>				<b>SEARCH NOTES (INCLUDING SEARCH STRATEGY)</b>		
Class	Subclass	Date	Examiner		DATE	EXMR
536	23.1	3/20/2005	NMM	see attached, WEST, NPL, PALM, STN, STIC commercial and interference sequence search of SEQ ID NO: 1, related applications	3/20/2005	NMM
	22.1			<i>Updated WEST (text only) SEQ 1, PALM</i>	9/07	mm
514	44					
<b>INTERFERENCE SEARCHED</b>						
Class	Subclass	Date	Examiner			